

SCBS262M-JULY 1993-REVISED NOVEMBER 2006

#### **FEATURES**

- Members of the Texas Instruments Widebus™
   Family
- Output Ports Have Equivalent 22- $\Omega$  Series Resistors, So No External Resistors Are Required
- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V<sub>CC</sub>)
- Support Unregulated Battery Operation Down to 2.7 V
- Typical V<sub>OLP</sub> (Output Ground Bounce) <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- I<sub>off</sub> and Power-Up 3-State Support Hot Insertion
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Distributed V<sub>CC</sub> and GND Pins Minimize High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

SN54LVTH162374... WD PACKAGE SN74LVTH162374... DGG OR DL PACKAGE (TOP VIEW)

	$\Box$		l	
1OE	1	48	Į	1CLK
1Q1	2	47	₽	1D1
1Q2	<b>[</b> ]3	46	<b>:</b> []	1D2
GND	4	45	; <b>[</b> ]	GND
1Q3	5	44	1	1D3
1Q4	6	43	1	1D4
$V_{CC}$	7	42	2	$V_{CC}$
1Q5	8	41		1D5
1Q6	9	40	╽	1D6
GND	10	39		GND
1Q7	11	38	1	1D7
1Q8	12	37	╽	1D8
2Q1	13	36	1	2D1
2Q2	14	35	<u> </u>	2D2
GND	15	34	1	GND
2Q3	16	33		2D3
2Q4	17	32	2	2D4
$V_{CC}$	18	31	þ	$V_{CC}$
2Q5	19	30	╽	2D5
2Q6	20	29		2D6
GND	21	28	1	GND
2Q7	22	27	1	2D7
2Q8	23	26	1	2D8
2 <mark>OE</mark>	24	25	•	2CLK

### **DESCRIPTION/ORDERING INFORMATION**

## **ORDERING INFORMATION**

T <sub>A</sub>	PACKAGI	<b>=</b> (1)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	FBGA – GRD	Deal of 4000	74LVTH162374GRDR	11.0074
	FBGA – ZRD (Pb-free)	Reel of 1000	74LVTH162374ZRDR	LL2374
		Tubo of 25	SN74LVTH162374DL	
	SSOP – DL	Tube of 25	SN74LVTH162374DLG4	L \/TLI400074
–40°C to 85°C	550P - DL	Reel of 1000	74LVTH16374DLRG4	LVTH162374
-40°C 10 65°C		Reel of 1000	SN74LVTH16374DLR	
	TOCOD DOC	Deal of 2000	SN74LVTH162374DGGR	L \/TLI462274
	TSSOP – DGG	Reel of 2000	74LVTH162374DGGRG4	LVTH162374
	VFBGA – GQL	Deal of 1000	SN74LVTH162374GQLR	11.0074
	VFBGA – ZQL (Pb-free)	Reel of 1000	74LVTH162374ZQLR	LL2374
-55°C to 125°C	CFP – WD	Tube	SNJ54LVTH162374WD	SNJ54LVTH162374WD

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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## **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

The 'LVTH162374 devices are 16-bit edge-triggered D-type flip-flops with 3-state outputs designed for low-voltage (3.3-V)  $V_{CC}$  operation, but with the capability to provide a TTL interface to a 5-V system environment. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

These devices can be used as two 8-bit flip-flops or one 16-bit flip-flop. On the positive transition of the clock (CLK), the Q outputs of the flip-flop take on the logic levels set up at the D inputs.

A buffered output-enable  $(\overline{OE})$  input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without need for interface or pullup components.

OE does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The outputs, which are designed to source or sink up to 12 mA, include equivalent  $22-\Omega$  series resistors to reduce overshoot and undershoot.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

When  $V_{CC}$  is between 0 and 1.5 V, the devices are in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

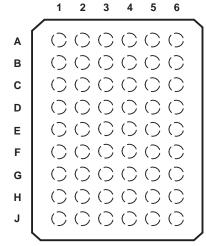
These devices are fully specified for hot-insertion applications using  $I_{off}$  and power-up 3-state. The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.



#### GQL OR ZQL PACKAGE (TOP VIEW)

		1	2	3	4	5	6	
Α				()	()	()		1
В		()	()	()	()	()	()	ı
С	(	()	()	()	()	()	()	ı
D	(	()	()	()	()	()	()	ı
Е	(	()	()			()	()	ı
F	(	()	()			()	()	ı
G	(	()	()	()	()	()	()	ı
н	(	()	()	()	()	()	()	ı
J	(	()	()	()	()	()	()	ı
K		()	()	()	()	()	()	J

# GRD OR ZRD PACKAGE (TOP VIEW)



# TERMINAL ASSIGNMENTS<sup>(1)</sup> (56-Ball GQL/ZQL Package)

	1	2	3	4	5	6
Α	1 <del>OE</del>	NC	NC	NC	NC	1CLK
В	1Q2	1Q1	GND	GND	1D1	1D2
С	1Q4	1Q3	V <sub>CC</sub>	V <sub>CC</sub>	1D3	1D4
D	1Q6	1Q5	GND	GND	1D5	1D6
E	1Q8	1Q7			1D7	1D8
F	2Q1	2Q2			2D2	2D1
G	2Q3	2Q4	GND	GND	2D4	2D3
Н	2Q5	2Q6	V <sub>CC</sub>	V <sub>CC</sub>	2D6	2D5
J	2Q7	2Q8	GND	GND	2D8	2D7
K	2 <del>OE</del>	NC	NC	NC	NC	2CLK

(1) NC - No internal connection

# TERMINAL ASSIGNMENTS<sup>(1)</sup> (54-Ball GRD/ZRD Package)

	1	2	3	4	5	6
Α	1Q1	NC	1 <del>OE</del>	1CLK	NC	1D1
В	1Q3	1Q2	NC	NC	1D2	1D3
С	1Q5	1Q4	$V_{CC}$	V <sub>CC</sub>	1D4	1D5
D	1Q7	1Q6	GND	GND	1D6	1D7
E	2Q1	1Q8	GND	GND	1D8	2D1
F	2Q3	2Q2	GND	GND	2D2	2D3
G	2Q5	2Q4	$V_{CC}$	V <sub>CC</sub>	2D4	2D5
Н	2Q7	2Q6	NC	NC	2D6	2D7
J	2Q8	NC	2 <mark>OE</mark>	2CLK	NC	2D8

(1) NC - No internal connection

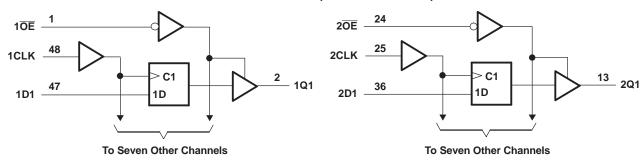
# FUNCTION TABLE (EACH FLIP-FLOP)

	INPUTS		OUTPUT
OE	CLK	D	Q
L	<b>↑</b>	Н	Н
L	$\uparrow$	L	L
L	H or L	Χ	$Q_0$
Н	X	Χ	Z

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## **LOGIC DIAGRAM (POSITIVE LOGIC)**



Pin numbers shown are for the DGG, DL, and WD packages.

# Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	4.6	V
VI	Input voltage range (2)		-0.5	7	V
Vo	Voltage range applied to any output in the h	igh-impedance or power-off state <sup>(2)</sup>	-0.5	7	V
Vo	Voltage range applied to any output in the h	igh state <sup>(2)</sup>	-0.5	V <sub>CC</sub> + 0.5	V
Io	Current into any output in the low state			30	mA
Io	Current into any output in the high state (3)			30	mA
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
		DGG package		70	
0	Dealers thereal impacts are (4)	DL package		63	0000
$\theta_{JA}$	Package thermal impedance (4)	GQL/ZQL package		42	°C/W
		GRD/ZRD package		36	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# Recommended Operating Conditions<sup>(1)</sup>

			SN54LVTH	162374	SN74LVTH1	162374	LIMIT
			MIN	MAX	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2.7	3.6	2.7	3.6	V
V <sub>IH</sub>	High-level input voltage		2		2		V
V <sub>IL</sub>	Low-level input voltage			0.8		0.8	V
VI	Input voltage			5.5		5.5	V
I <sub>OH</sub>	High-level output current			-12		-12	mA
I <sub>OL</sub>	Low-level output current			12		12	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate	·	200		200		μs/V
T <sub>A</sub>	Operating free-air temperature		-55	125	-40	85	°C

<sup>(1)</sup> All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(3)</sup> This current flows only when the output is in the high state and  $V_O > V_{CC}$ .

<sup>(4)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.



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## **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

		IETER TEST CONDITIONS SN54LVTH162374 SN74LVTH1623		2374	LINUT				
ı	PARAMETER	IESI	CONDITIONS	MIN TYP(1)	MAX	MIN	TYP <sup>(1)</sup>	MAX	UNIT
$V_{IK}$		$V_{CC} = 2.7 \text{ V},$	$I_1 = -18 \text{ mA}$		-1.2			-1.2	V
$V_{OH}$		$V_{CC} = 3 V$ ,	$I_{OH} = -12 \text{ mA}$	2		2			V
V <sub>OL</sub>		V <sub>CC</sub> = 3 V,	I <sub>OL</sub> = 12 mA		0.8			0.8	V
		$V_{CC} = 0 \text{ or } 3.6 \text{ V},$	V <sub>I</sub> = 5.5 V		10			10	
	Control inputs	$V_{CC} = 3.6 \text{ V},$	$V_I = V_{CC}$ or GND		±1			±1	^
l <sub>l</sub>	Data issues	V 26V	$V_I = V_{CC}$		1			1	μΑ
	Data inputs	V <sub>CC</sub> = 3.6 V	V <sub>I</sub> = 0		-5			<b>-</b> 5	
I <sub>off</sub>	1	$V_{CC} = 0$ ,	$V_I$ or $V_O = 0$ to 4.5 V					±100	μΑ
		.,	V <sub>I</sub> = 0.8 V	75		75			
I	Data inputs	$V_{CC} = 3 V$	V <sub>I</sub> = 2 V	-75		-75			μΑ
I <sub>I(hold)</sub>	Data Inputs	V <sub>CC</sub> = 3.6 V, <sup>(2)</sup>	V <sub>I</sub> = 0 to 3.6 V					500 -750	μΑ
I <sub>OZH</sub>	1	V <sub>CC</sub> = 3.6 V,	V <sub>O</sub> = 3 V		5			5	μΑ
I <sub>OZL</sub>		$V_{CC} = 3.6 \text{ V},$	V <sub>O</sub> = 0.5 V		-5			<b>-</b> 5	μΑ
I <sub>OZPU</sub>		$\frac{V_{CC}}{OE}$ = 0 to 1.5 V, V <sub>O</sub>	= 0.5 V to 3 V,		±100 <sup>(3)</sup>			±100	μΑ
I <sub>OZPD</sub>		$\frac{V_{CC}}{OE}$ = 1.5 V to 0, $V_{O}$	= 0.5 V to 3 V,		±100 <sup>(3)</sup>			±100	μΑ
		V <sub>CC</sub> = 3.6 V,	Outputs high		0.19			0.19	
$I_{CC}$		$I_{O} = 0$ ,	Outputs low		5			5	mA
		$V_I = V_{CC}$ or GND	Outputs disabled		0.19			0.19	
ΔI <sub>CC</sub> <sup>(4)</sup>		$V_{CC}$ = 3 V to 3.6 V, C Other inputs at $V_{CC}$ of	One input at V <sub>CC</sub> – 0.6 V, or GND		0.2			0.2	mA
Ci		V <sub>I</sub> = 3 V or 0		3			3		pF
C <sub>o</sub>		V <sub>O</sub> = 3 V or 0		9			9		pF

<sup>(1)</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

## **Timing Requirements**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			SN	I54LVTI	1162374		SI	N54LVT	H162374		
			$V_{CC}$ = 3.3 V $\pm$ 0.3 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 2.7 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency			160		160		160		160	MHz
t <sub>w</sub>	Pulse duration, CLK high or low		3		3.3		3		3		ns
t <sub>su</sub>	Setup time, data before CLK↑	High or low	2.8		3.2		1.8		2		ns
t <sub>h</sub>	Hold time, data after CLK↑	High or low	1.2		0.5		0.8		0.1		ns

<sup>(2)</sup> This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

<sup>(3)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>(4)</sup> This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

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# **Switching Characteristics**

over recommended operating free-air temperature range,  $C_L = 50 \text{ pF}$  (unless otherwise noted) (see Figure 1)

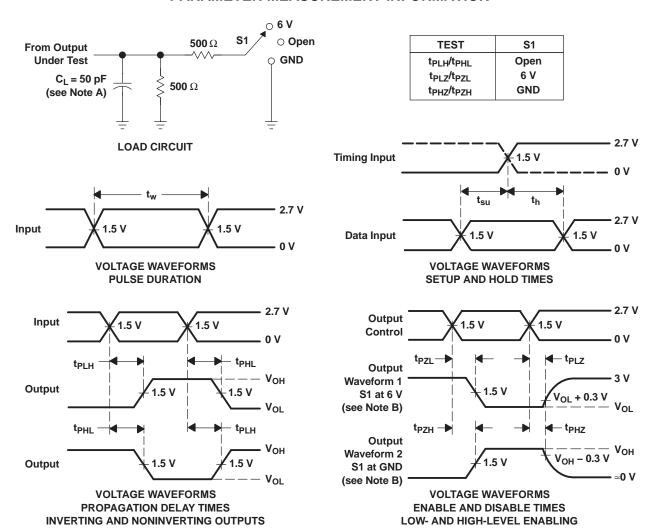
			SNS	4LVTF	1162374	4		SN74L	VTH16	2374		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 3 ± 0.3	$V_{CC}$ = 3.3 V $\pm$ 0.3 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V			2.7 V	UNIT
			MIN	MAX	MIN	MAX	MIN	TYP <sup>(1)</sup>	MAX	MIN	MAX	
f <sub>max</sub>			160		160		160			160		MHz
t <sub>PLH</sub>	CLK	Q	1.4	6.6		7.4	2	3.4	5.3		6.2	ns
t <sub>PHL</sub>	CLK	y	1.4	5.8		6	2.2	3.3	4.9		5.1	115
t <sub>PZH</sub>	ŌĒ	Q	1	6.6		7.4	1.8	3.5	5.6		6.9	
t <sub>PZL</sub>	OE	Q	1.4	6		6.8	1.8	3.5	4.9		6	ns
t <sub>PHZ</sub>	ŌĒ	Q	1	6.6		7.4	2.4	4.2	5.4		5.7	no
t <sub>PLZ</sub>	OE	Q	1.4	6		6	2	3.8	5		5.1	ns
t <sub>sk(LH)</sub>									0.5			no
t <sub>sk(HL)</sub>									0.5			ns

<sup>(1)</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C.



WITH 3-STATE OUTPUTS
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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_r \leq$  2.5 ns.  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

# **PACKAGE OPTION ADDENDUM**



8-Oct-2017

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type		Pins	_		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-9854201QXA	LIFEBUY	CFP	WD	48	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9854201QX A SNJ54LVTH16237 4WD	
5962-9854201VXA	ACTIVE	CFP	WD	48	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9854201VX A SNV54LVTH16237 4WD	Samples
74LVTH162374DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVTH162374	Samples
74LVTH162374ZQLR	ACTIVE	BGA MICROSTAR JUNIOR	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	LL2374	Samples
74LVTH162374ZRDR	ACTIVE	BGA MICROSTAR JUNIOR	ZRD	54	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	LL2374	Samples
SN74LVTH162374DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVTH162374	Samples
SN74LVTH162374DL	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVTH162374	Samples
SN74LVTH162374DLR	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVTH162374	Samples
SNJ54LVTH162374WD	LIFEBUY	CFP	WD	48	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9854201QX A SNJ54LVTH16237 4WD	

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

#### PACKAGE OPTION ADDENDUM



8-Oct-2017

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54LVTH162374, SN54LVTH162374-SP, SN74LVTH162374:

■ Catalog: SN74LVTH162374, SN54LVTH162374

Military: SN54LVTH162374

Space: SN54LVTH162374-SP

NOTE: Qualified Version Definitions:

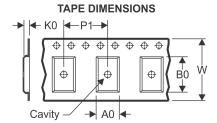
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

# **PACKAGE MATERIALS INFORMATION**

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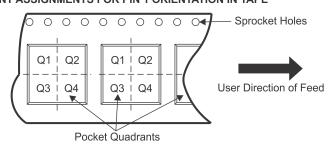
# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

All difficults are normal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74LVTH162374ZQLR	BGA MI CROSTA R JUNI OR	ZQL	56	1000	330.0	16.4	4.8	7.3	1.5	8.0	16.0	Q1
74LVTH162374ZRDR	BGA MI CROSTA R JUNI OR	ZRD	54	1000	330.0	16.4	5.8	8.3	1.55	8.0	16.0	Q1
SN74LVTH162374DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1
SN74LVTH162374DLR	SSOP	DL	48	1000	330.0	32.4	11.35	16.2	3.1	16.0	32.0	Q1



# **PACKAGE MATERIALS INFORMATION**

www.ti.com 11-Mar-2017



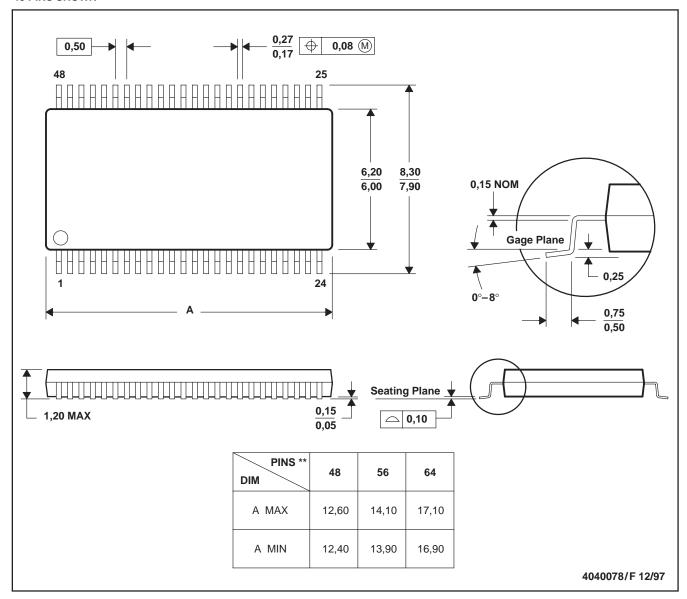
#### \*All dimensions are nominal

All difficions die nominal											
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)				
74LVTH162374ZQLR	BGA MICROSTAR JUNIOR	ZQL	56	1000	336.6	336.6	28.6				
74LVTH162374ZRDR	BGA MICROSTAR JUNIOR	ZRD	54	1000	336.6	336.6	28.6				
SN74LVTH162374DGGR	TSSOP	DGG	48	2000	367.0	367.0	45.0				
SN74LVTH162374DLR	SSOP	DL	48	1000	367.0	367.0	55.0				

# DGG (R-PDSO-G\*\*)

# PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

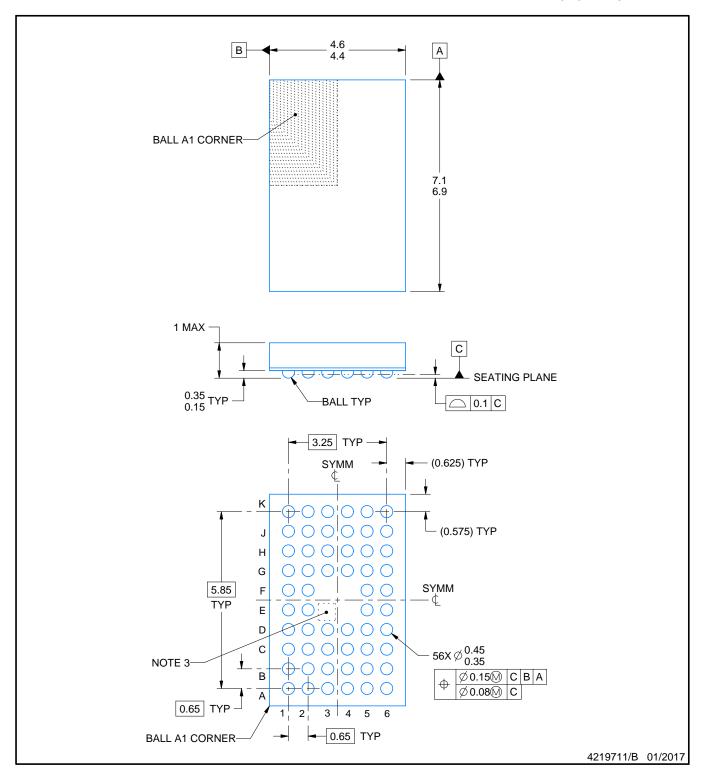
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153



PLASTIC BALL GRID ARRAY



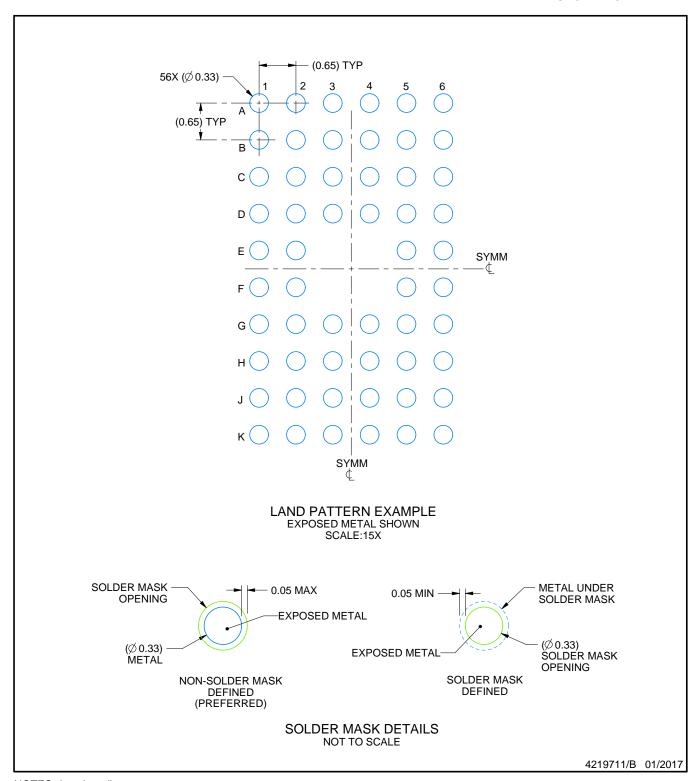
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.
- 3. No metal in this area, indicates orientation.



PLASTIC BALL GRID ARRAY

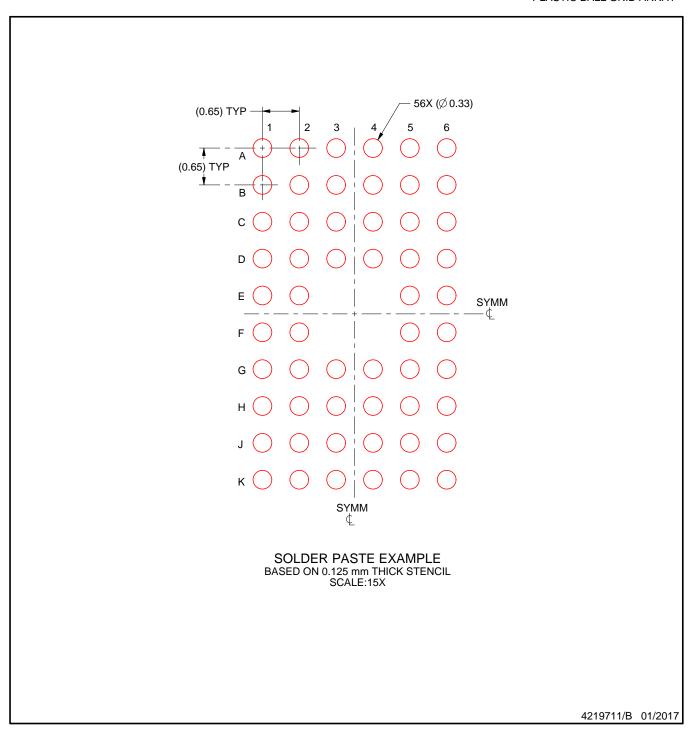


NOTES: (continued)

4. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For information, see Texas Instruments literature number SPRAA99 (www.ti.com/lit/spraa99).



PLASTIC BALL GRID ARRAY



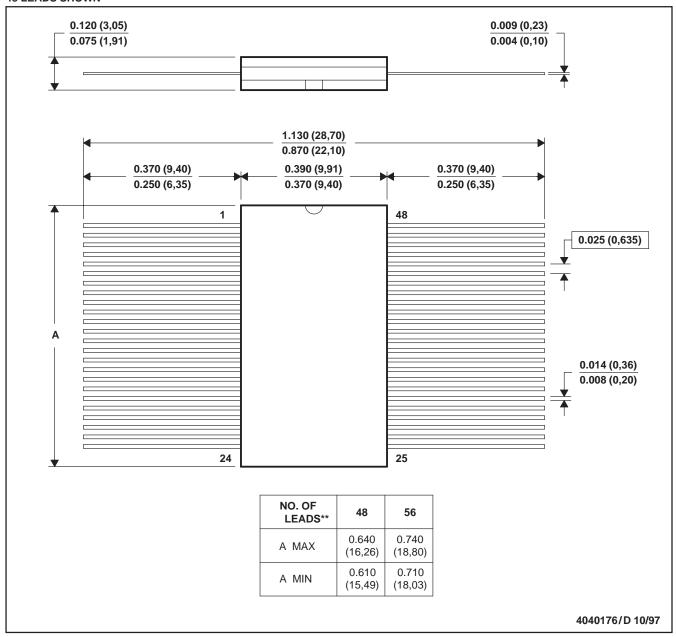
NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

## WD (R-GDFP-F\*\*)

#### **CERAMIC DUAL FLATPACK**

#### **48 LEADS SHOWN**



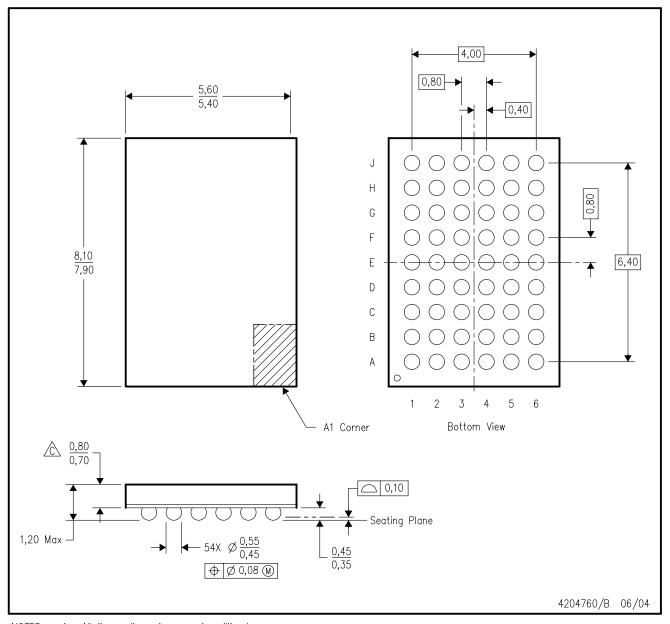
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only
- E. Falls within MIL STD 1835: GDFP1-F48 and JEDEC MO-146AA GDFP1-F56 and JEDEC MO-146AB



# ZRD (R-PBGA-N54)

# PLASTIC BALL GRID ARRAY



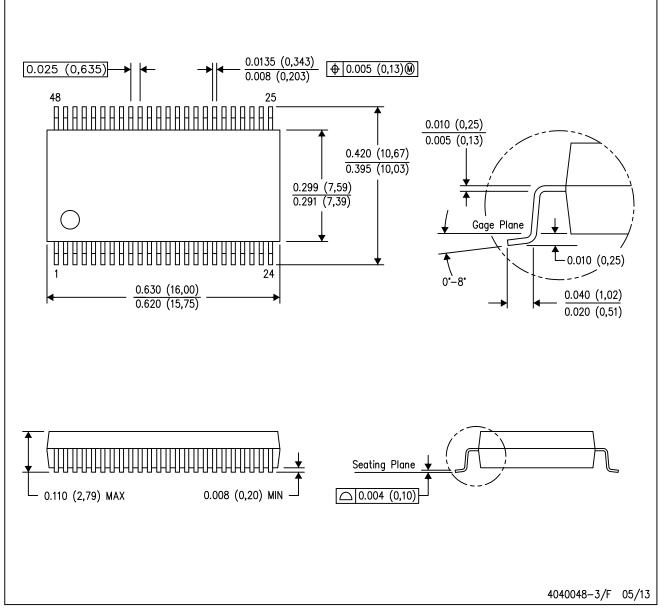
 $\hbox{NOTES:} \quad \hbox{A. All linear dimensions are in millimeters.}$ 

- B. This drawing is subject to change without notice.
- Falls within JEDEC MO-205 variation DD.
- D. This package is lead-free. Refer to the 54 GRD package (drawing 4204759) for tin-lead (SnPb).



DL (R-PDSO-G48)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

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